

**Search Notes**

Application/Control No.

10/662,819

Examiner

Dana Farahani

Applicant(s)/Patent under  
Reexamination

EBE ET AL.

Art Unit

2891

**SEARCHED**

Class	Subclass	Date	Examiner
257	14	5/11/2005	DF
"	15	5/11/2005	DF
"	16	5/11/2005	DF
"	17	5/11/2005	DF
"	18	5/11/2005	DF
"	19	5/11/2005	DF
"	23	5/11/2005	DF
"	25	5/11/2005	DF
438	962	5/21/2005	DF
977	DIG 1	5/21/2005	DF

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
"257"/\$.ccls. and (quantum adj dot\$1) and (InGaAsP or InAlGaAs or InAlGaP)	5/11/2005	df
"257"/\$.ccls. and (quantum adj dot\$1) and (InGaAsP)	5/11/2005	DF
257/14-26. and (InGaAsP)	5/11/2005	DF
257/14-26. and (InGaAsP or InAlGaAs or InAlGaP)	5/11/2005	DF
quantum adj dot\$1	5/11/2005	DF
((nano\$1particle\$1 or nano\$1dot\$1 or (artificial adj atom) or (dimensional adj dot))	5/21/2005	DF
((quantum adj dot\$1) and ((increas\$3 or decreas\$3) with (concentration or composition)))	5/21/2005	DF
((quantum adj dot\$1) and ((increas\$3 or decreas\$3 or gradual\$3) with (co	5/21/2005	DF